

UNCLASSIFIED

AD 414847

DEFENSE DOCUMENTATION CENTER

FOR

SCIENTIFIC AND TECHNICAL INFORMATION

CAMERON STATION, ALEXANDRIA, VIRGINIA



UNCLASSIFIED

NOTICE: When government or other drawings, specifications or other data are used for any purpose other than in connection with a definitely related government procurement operation, the U. S. Government thereby incurs no responsibility, nor any obligation whatsoever; and the fact that the Government may have formulated, furnished, or in any way supplied the said drawings, specifications, or other data is not to be regarded by implication or otherwise as in any manner licensing the holder or any other person or corporation, or conveying any rights or permission to manufacture, use or sell any patented invention that may in any way be related thereto.

63-4-5

CONTRACT AF 33(616)-8438
PROJECT 7381; TASK 738103

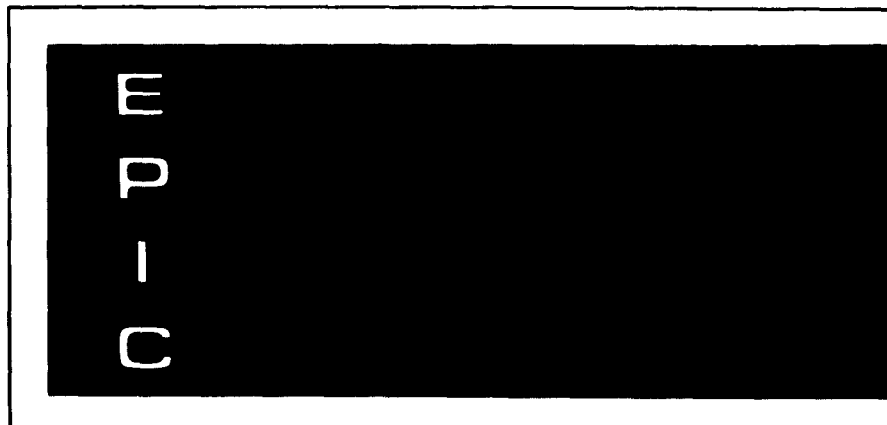
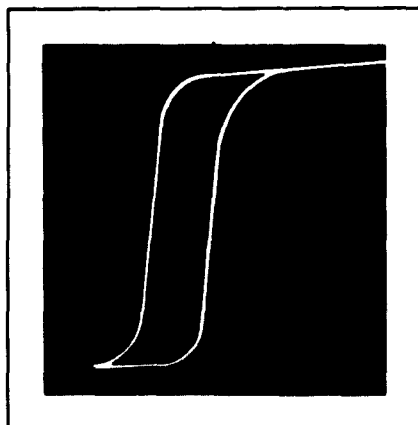
CATALOGED BY DDC
AS AD No. 414847
414847

INDIUM PHOSPHIDE

Data Sheets

M. Neuberger

DS-102
June 1962



HUGHES

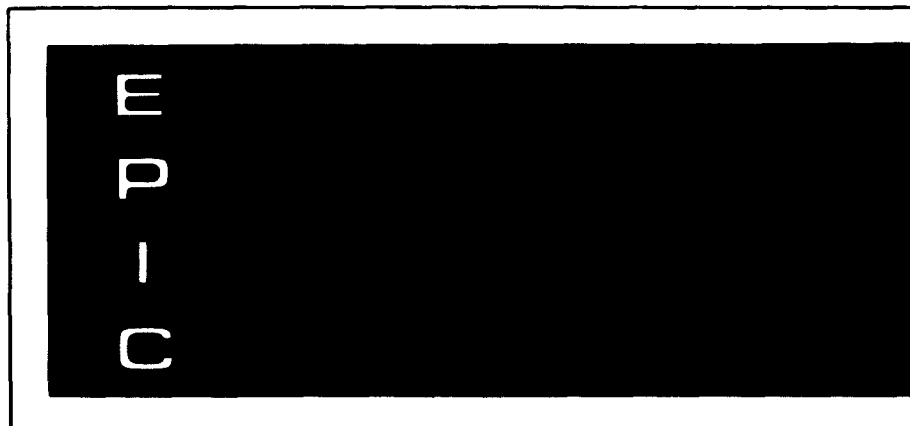
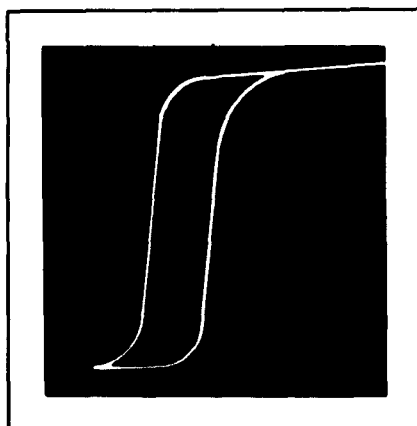
HUGHES AIRCRAFT COMPANY
CULVER CITY, CALIFORNIA

INDIUM PHOSPHIDE

Data Sheets

M. Neuberger

DS-102
June 1962



HUGHES

HUGHES AIRCRAFT COMPANY
CULVER CITY, CALIFORNIA

FOREWORD

This report was prepared by Hughes Aircraft Company under Contract No. AF 33(616)-8438. The contract was initiated under Project No. 7381, Task No. 738103. The work was administered under the direction of the Directorate of Materials and Processes, Aeronautical Systems Division, with Mr. R.F. Klinger acting as Project Engineer.

Many persons have contributed to the program which this report represents. The author wishes especially to acknowledge the contributions of the following: J.J. Anders, J.W. Atwood, C.L. Blocher, D.L. Grigsby, J.J. Grossman, F.S. Harter, D.H. Johnson, H.T. Johnson, J.T. Milek, G.S. Picus, and E. Schafer.

ABSTRACT

The Electronic Properties Information Center has been established to collect, index and abstract the literature on the electrical and electronic properties of materials and to evaluate and compile the experimental data from that literature. A modified coordinate index to the literature is machine stored and printed for manual use. The Center publishes data sheets, summary reports, thesauri, glossaries, and similar publications as sufficient information is evaluated and compiled. This report consists of the compiled data sheets on Indium Phosphide.

This report has been reviewed and is approved for publication.


H. Thayne Johnson, Supervisor
Electronic Properties Information Center


John W. Atwood
Project Manager

TABLE OF CONTENTS

	Page
Foreword	11
Abstract	111
Introduction	1
Absorption	4
Dielectric Constant	9
Effective Mass	10
Electrical Conductivity	11
Energy Band Structure	14
Energy Gap	14
Energy Level	14
Hall Coefficient	15
Irradiation Effects	16
Lifetime	16
Magnetoelectric Properties	17
Mobility	19
Photoelectronic Properties	23
Piezoelectric Properties	23
Reflectivity	24
Refractive Index	25
Thermoelectric Properties	25
References	26
Publications of the Electronic Properties Information Center . .	28

INTRODUCTION

In June 1961, a program was initiated under the direction of the Air Force to collect, index and abstract the literature on the electrical and electronic properties of materials and to evaluate and compile the experimental data from that literature. Placed at Hughes Aircraft Company in Culver City, California, the program, now called the Electronic Properties Information Center, was originally intended to cover ten major categories of materials: Semiconductors, Insulators, Ceramics, Ferroelectrics, Metals, Ferrites, Ferromagnetics, Electroluminescent Materials, Thermionic Emitters, and Superconductors.

During the first year, studies were completed on the Semiconductor and Insulator categories; and Ceramics was discontinued as a separate category and subsumed under the other nine. Vocabulary studies have now been completed on all categories, and retrospective documentation is virtually complete for Semiconductors and Insulators. A full index to the literature is maintained; and publications such as data sheets, summary reviews, glossaries, and thesauri are periodically issued. The use of the Center and these publications are available to anyone wishing information within the scope of the Center's objectives. A full list of publications to date appears at the end of this report.

This report contains data sheets on Indium Phosphide. The data sheets have been compiled direct from the literature. Articles are allowed to accumulate in the system until it is judged that a sufficient number are available on one material for adequate evaluation. The

manual modified coordinate index is then used to retrieve all literature on the material to be compiled. Bibliographies are checked to make sure that valuable and relevant literature is not overlooked. Then the assembled literature is given to the specialist doing the evaluation and compilation.

Evaluation is confined to primary source data except when only secondary citations are available. If equally valid data are available from several sources, all are given. Data are rejected when judged questionable because of faulty or dubious measurements, unknown sample composition, or if more reliable data are available from another source. Selection of data is based upon that which is judged most representative, precise, reliable, and covers the widest range of variables. The addition of new data to a previously evaluated property requires a reappraisal of the reported values. Older data may be deleted if the new data are judged more accurate or representative.

After a thorough analysis and evaluation, the data is compiled into data sheets which present it in its most optimum form. This will be, primarily, but not limited to, curves or tabular form. Where possible, graphs are adapted directly from the original sources. If this is not possible, they are drawn from data compiled from the articles. Where thought important, notes are entered with each graph to help the user.

The references, from which the data are drawn, are shown by

reference number below each graph with the full bibliographic information at the end of the data sheets. The bibliography is referred to and listed in the order of entry into the Center (accession number). This provides a quick cross reference into the index used with the literature.

These data sheets were originally issued in loose leaf form in June 1962. In response to numerous additional requests for copies, they are being reissued at this time.

This compilation deals only with Indium Phosphide as a Semiconductor. Non-semiconductor data will be included in a future revision.

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

MATERIALS CENTRAL

AERONAUTICAL SYSTEMS DIVISION

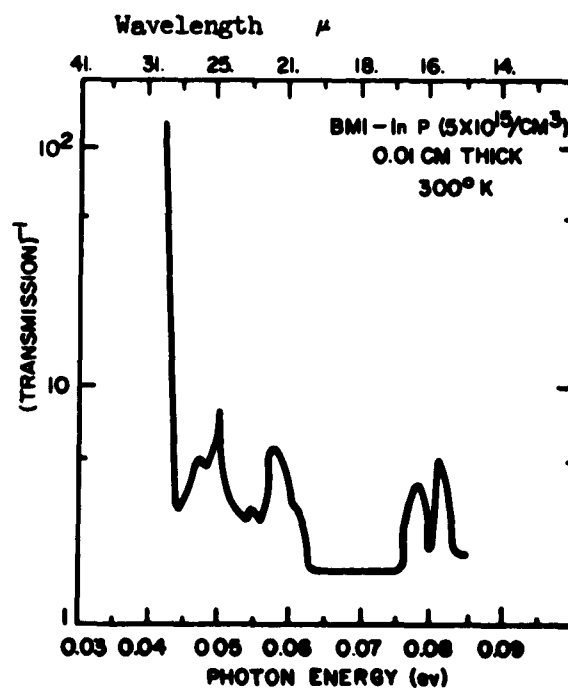
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Absorption



Absorption spectrum (300°K) of an InP sample in the reststrahlen region. (n-type single crystal) [Ref. 13]

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

MATERIALS CENTRAL

AERONAUTICAL SYSTEMS DIVISION

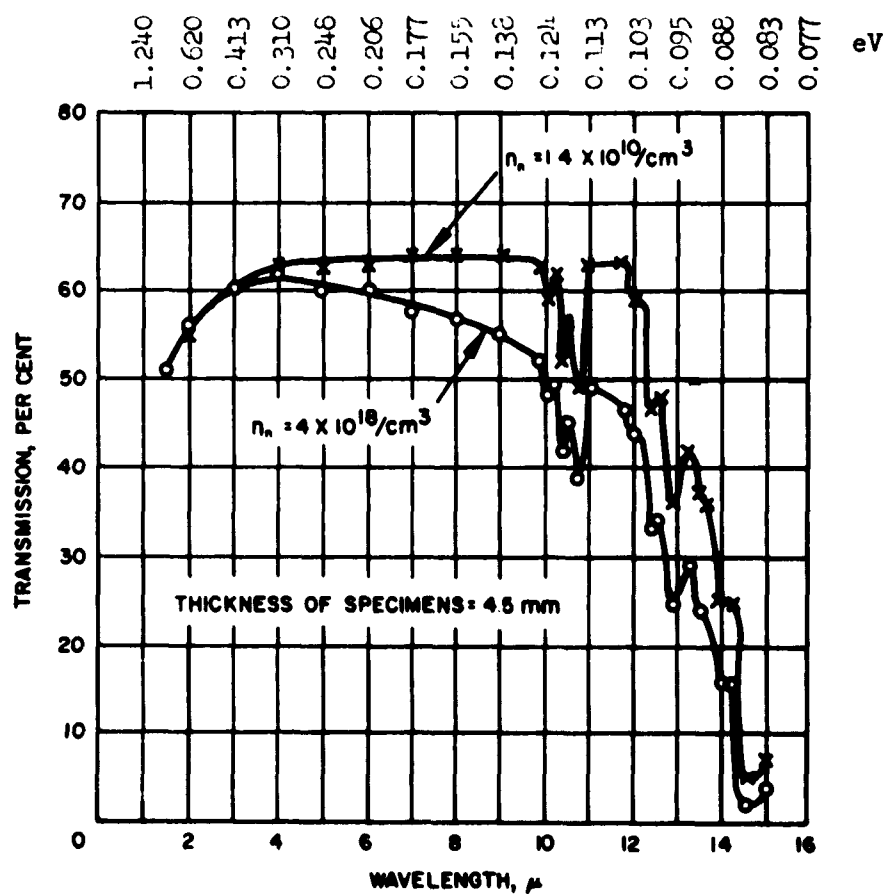
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Absorption



Transmission characteristics of two n-type single-crystal specimens of InP at 300°K.

[Ref. 9]

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

MATERIALS CENTRAL

AERONAUTICAL SYSTEMS DIVISION

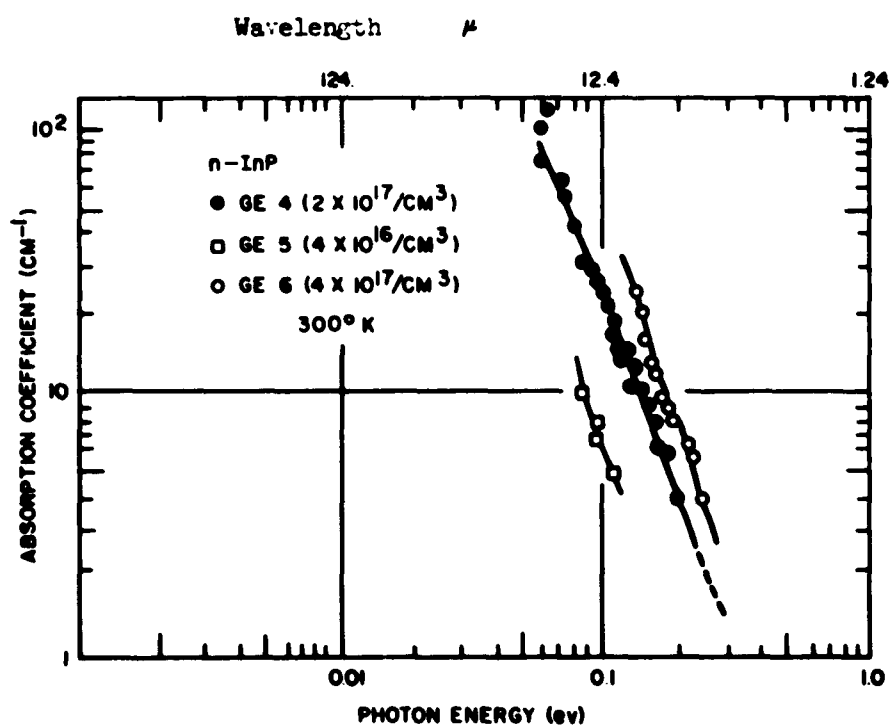
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Absorption



Free-carrier absorption (300°K) in various InP samples.
(single crystal)

[Ref. 13]

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

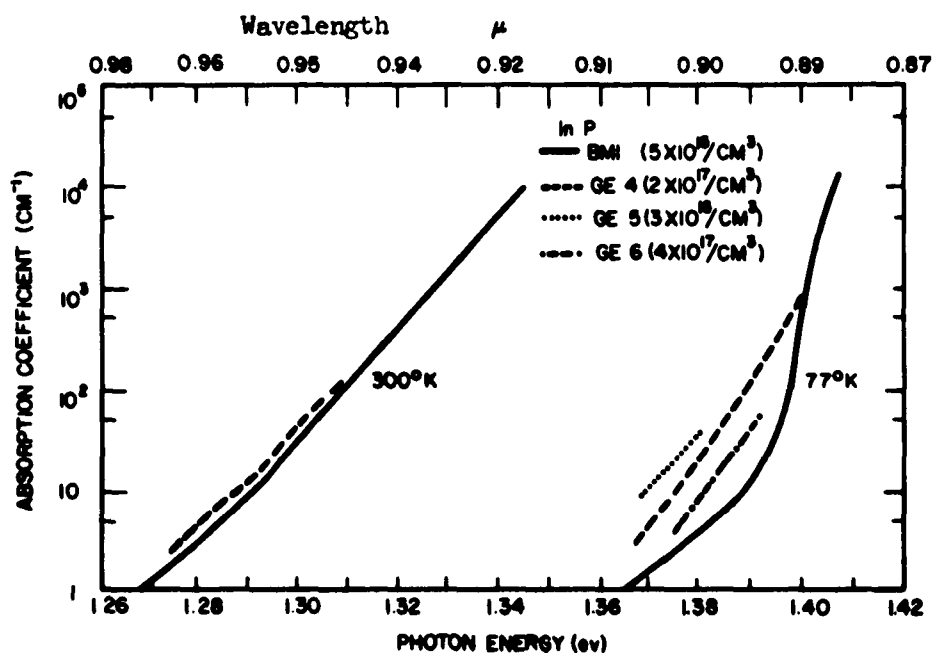
MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Absorption



Intrinsic absorption edge of InP at 77°K and 300°K. The [Ref.13]
different curves refer to different ingots.
n-type, single crystal.

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

MATERIALS CENTRAL

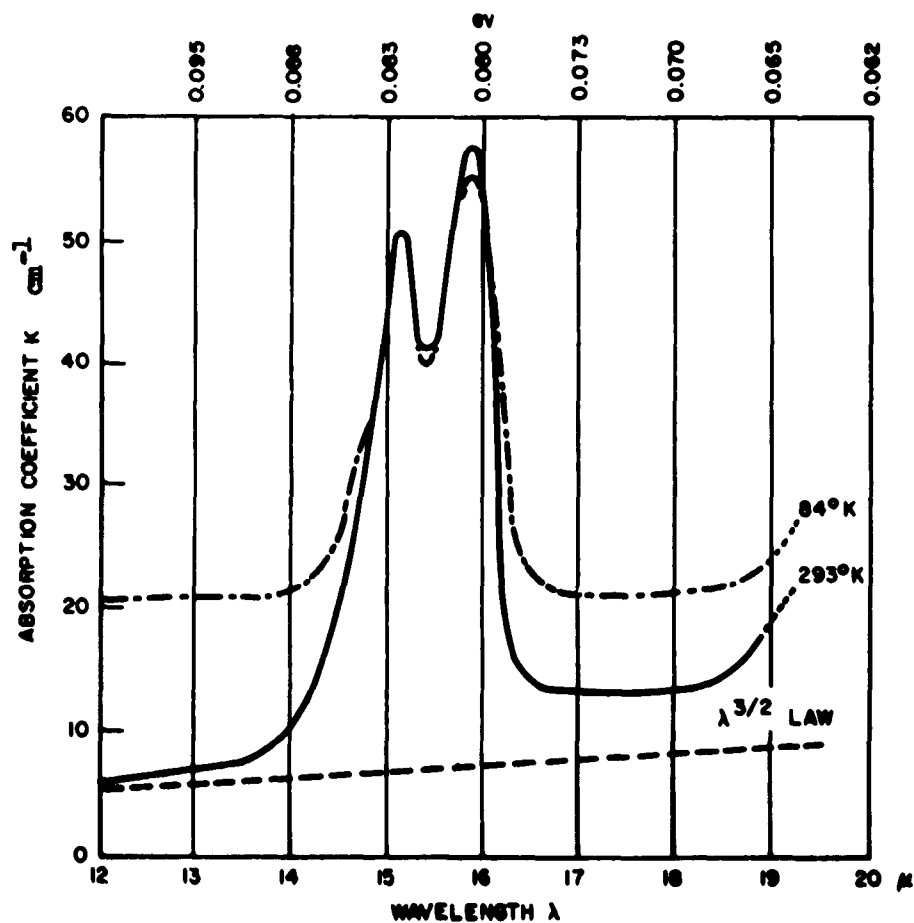
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Absorption



Infra-red absorption curves for n-type indium phosphide at 293°K and 84°K . The broken line corresponds to $K \propto \lambda^{1.5}$. (probably single-crystal)

[Ref. 18]

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

MATERIALS CENTRAL

AERONAUTICAL SYSTEMS DIVISION

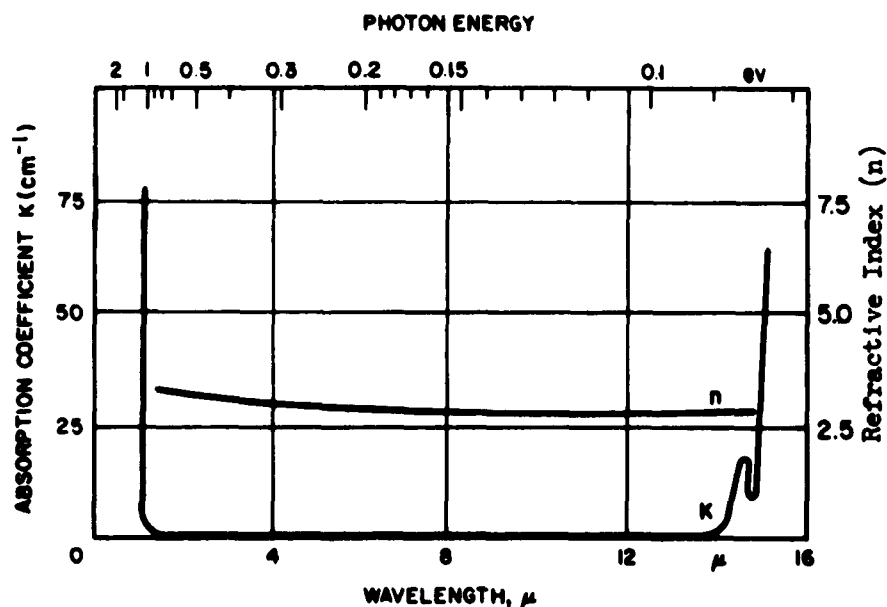
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Absorption



Indium Phosphide; $\rho = 0.1 \Omega\text{cm}$, n-type, poly-crystal. [Ref. 15]
 $n = 3.1$ in infra-red.

Dielectric Constant

<u>Symbol</u>	<u>Value</u>	<u>Type</u>	<u>Test Conditions</u>	<u>Ref.</u>
ϵ	15	n-single	300°K photon freq. = 0.040eV	13
	10.6		300°K photon freq. = 0.060eV to band edge	13

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Effective Mass

Symbol	Value	Type	Test Conditions	Ref.
m_p^*	$0.69 m_0$	n-Poly		12
m_n^*	$\rightarrow 0.077 m_0 \pm 0.005$		$n_n = 6.1 \times 10^{15}/\text{cm}^3$ $\mu = 18,600 \text{ cm}^2/\text{V sec}$	17
	$\rightarrow 0.073 m_0 \pm 0.007$	n-Poly	Faraday effect data	12
	$0.02 m_0$	n-Poly	84°K, optical data	18
m^*	$0.2 m_0$	n-Single Intrinsic	$n_n = 5 \times 10^{18}/\text{cm}^3$, optical data	13
	$0.2-0.8 m_0$	p	Cd-doped, mobility data	5
	$0.23 m_0$	p-Poly Intrinsic	Conductivity measurements	4
	$0.10 m_0$		Faraday rotation, $\lambda = 2-17 \mu$ room temperature $n_n = 1.1-1.17 \times 10^{17}/\text{cm}^3$	1

$\rightarrow$ Best values

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

MATERIALS CENTRAL

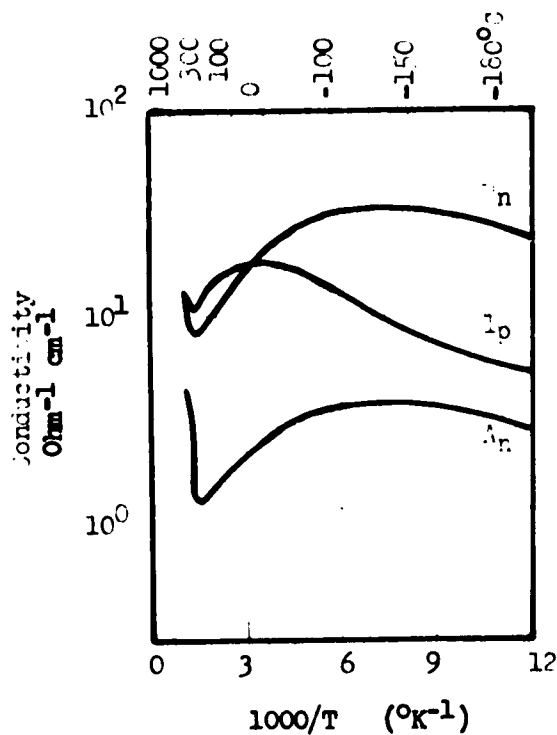
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Electrical Conductivity



A_n = n-type, 4×10^{15} electrons/ cm^3 , 300°C
 B_n = n-type
 I_p = p-type, prepared by diffusion of zinc into A_n
 T° = -180° to 960°C

[Ref. 4]

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

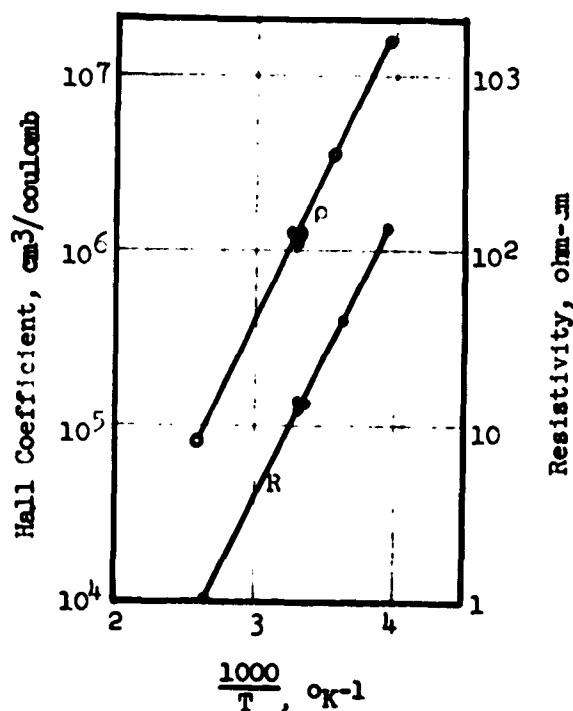
MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Electrical Conductivity



Before irradiation $R = -59 \text{ cm}^3/\text{coulomb}$

$\rho = 0.0179 \text{ } \Omega \text{ cm}$ and

$\mu_H = 3300 \text{ cm}^2/\text{volt sec.}$

n-type, single crystal, 250-360°K.

Temperature dependence of Hall coefficient, R , and resistivity, ρ , of InP sample after fast neutron irradiation.

[Ref. 2]

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

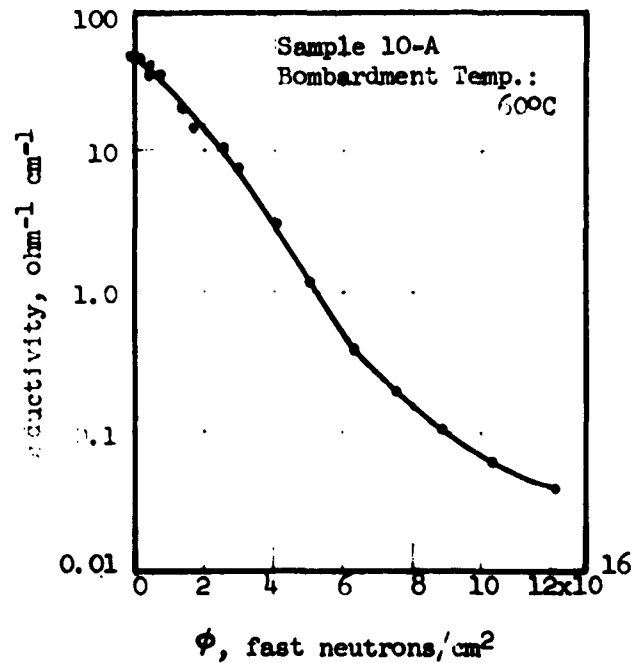
MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Electrical Conductivity



Irradiation of n-type InP; variation in conductivity with total neutron irradiation.

[Ref. 2]

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

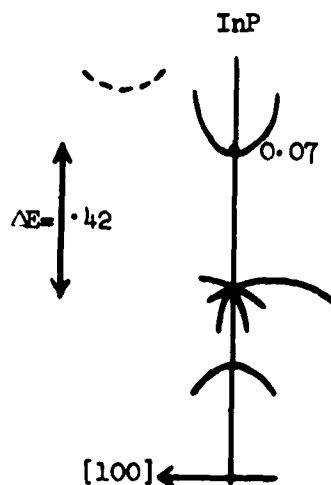
MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Energy Band Structure



Probable band structure of Indium phosphide. Effective conduction band mass and 0°K band gap are indicated. [Ref. 10]

Energy Gap

	Value	Sample	Temperature	Ref.
E_g	1.34 eV	Polycrystalline (n or p-type)	0°K	4
	$1.41 - 4.6 \times 10^{-4}$	Polycrystalline ($\rho = 0.23 \text{ ohm cm}$)	0°K	14
	1.36		109°K	18
	1.27 ± 0.01		293°K	18
	1.25		300°K	11

Energy Level

E_i	0.026 eV	Single Crystalline, p-type $n = 8.5 \times 10^{17}/\text{cm}^3$ $n = 3 \times 10^{16}/\text{cm}^3$ cadmium impurity	77-290°K	5
	0.047 eV			

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

MATERIALS CENTRAL

AERONAUTICAL SYSTEMS DIVISION

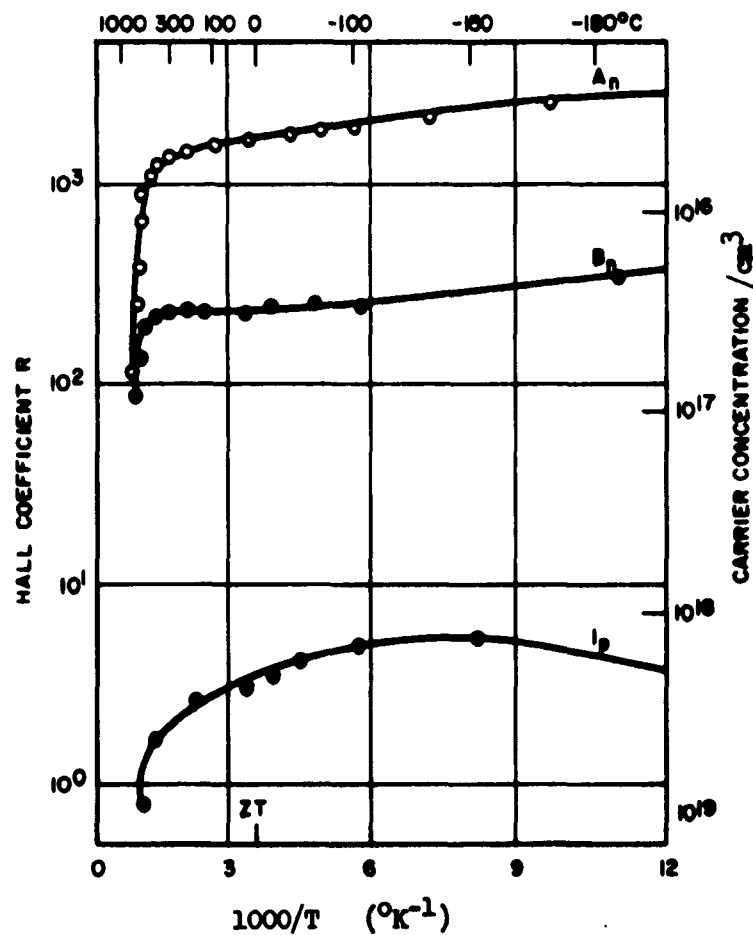
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Hall Coefficient



Hall coefficient and carrier concentration of two n- and one p-conducting indium phosphide compounds.

[Ref. 4]

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Irradiation Effects

See Electrical Conductivity

Lifetime--Diffusion Length

<u>Symbol</u>	<u>Value</u>	<u>Type</u>	<u>Test Conditions</u>	<u>Ref.</u>
L_n	130 μ = 0.13 mm	p-n junction, single		6
τ_i	2×10^{-6} sec.			6
L	0.2 mm (est.)		From photoconductive threshold	18
τ	5×10^{-6} sec. (est.)			18

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Magnetoelectric Properties

Crystal	Hall mobility (cm ² /V-sec)	Electron concentration (cm ⁻³)	Temperature (°K)	Magnetoresistance $\frac{\Delta\rho}{\rho_0 H^2}$ (10 ⁶ cm ⁴ /v ² -sec ²)		
				I [110] H [110]	I [110] H [001]	I [110] H [110]
192†	4600	6 x 10 ¹⁵	292	0.02	1.11	1.09††
192	4200	6 x 10 ¹⁵	294	0.05	1.3	1.5
54	2800	6 x 10 ¹⁵	290	0.37	1.15	1.22
T43	4300	4.3 x 10 ¹⁶	293	0.20	0.66	0.25
T43†	4000	5 x 10 ¹⁶	292	0.02	0.28	0.21††
51	3150	1.2 x 10 ¹⁷	290	0.03	0.13	0.10
1	3150	1.4 x 10 ¹⁷	289	0.31	0.55	0.26
T5†	2750	4.6 x 10 ¹⁷	293	0.02	0.14	0.10††
T43	8700	4.3 x 10 ¹⁶	77	0.6	8.2	6.6
T43†	6900	5 x 10 ¹⁶	77	0.09	6.2	5.8 ††

† The side contacts were 0.002 in. diameter gold wires welded to the crystal.

†† Purest

Magnetoresistance of n-type InP. In the conventional notation three coefficients b, c, and d may be defined by

$$\frac{\Delta\rho}{\rho_0 H^2} = b + \frac{(I \cdot H)^2}{I^2 H^2} c + \frac{\sum I_i^2 H_i^2}{I^2 H^2} d.$$

The last three columns of Table refer respectively to measurements of b + c + 1/2d, b, and b + 1/2d.

[Ref. 7]

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

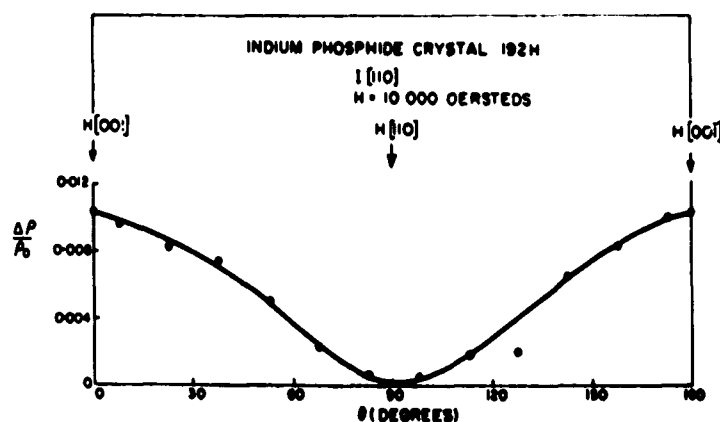
MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

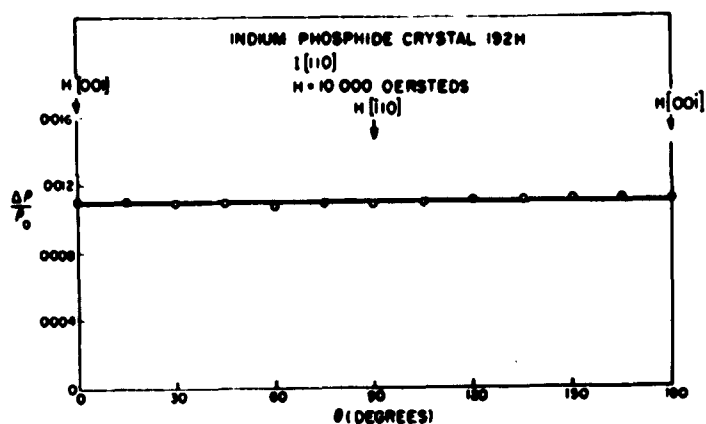
INDIUM PHOSPHIDE

Magnetoelectric Properties



The magnetoresistance of n-type InP crystal 192 as a function of the angle the magnetic field makes with the [001] direction in the (110) plane. The temperature was 292°K.

[Ref. 7]



The magnetoresistance of n-type InP crystal 192 as a function of the angle the magnetic field makes with the [001] direction in the (110) plane. The temperature was 292°K.

[Ref. 7]

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

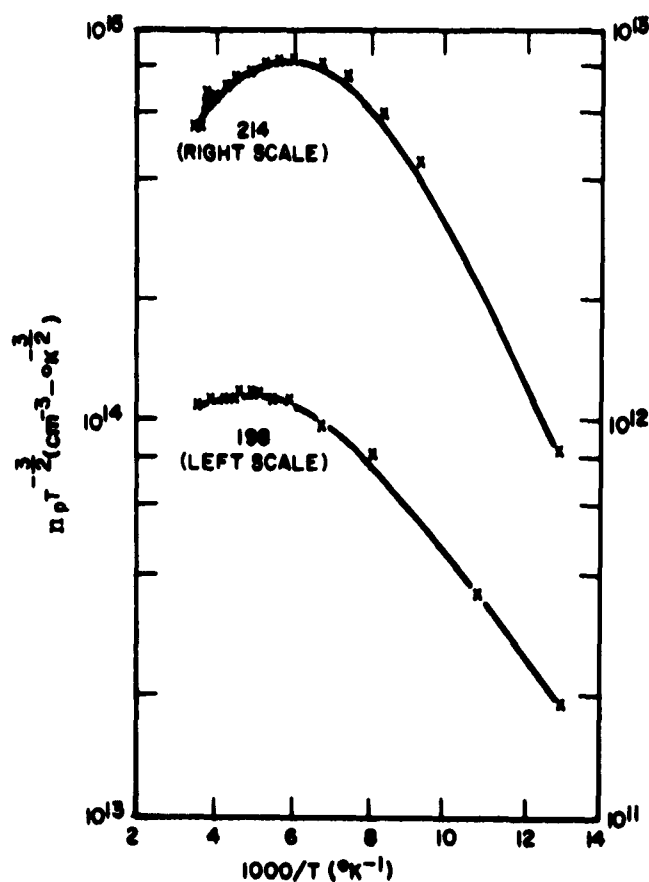
MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Mobility



The product of hole concentration and (temperature)^{-1.5} as a function of 1/T. The slope at low temperatures was used to estimate the ionization energy.

[Ref. 5]

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

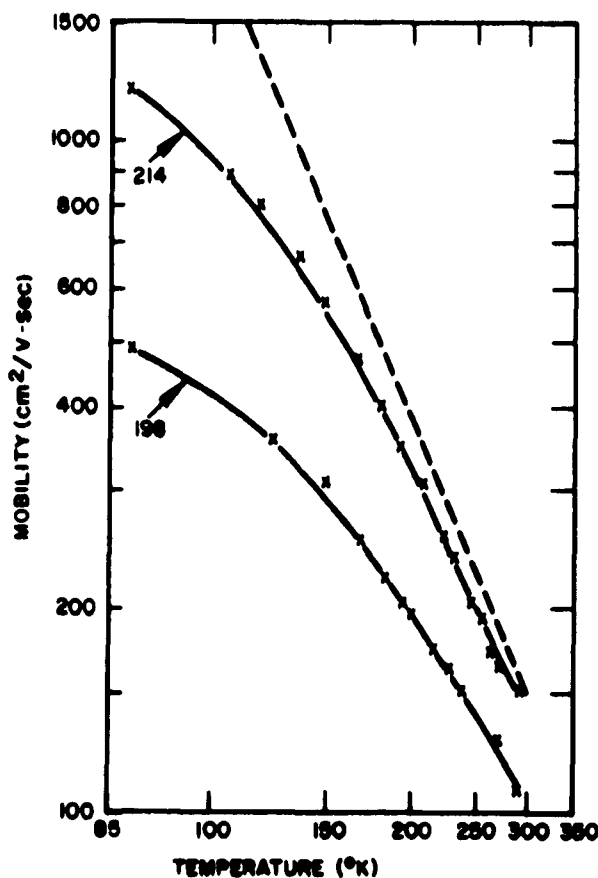
MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Mobility



The Hall mobility of p-type InP crystals as a function of temperature. The dashed curve is the lattice mobility calculated from the 214 curve, assuming $m^* = 0.2m_0$.

[Ref. 5]

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

MATERIALS CENTRAL

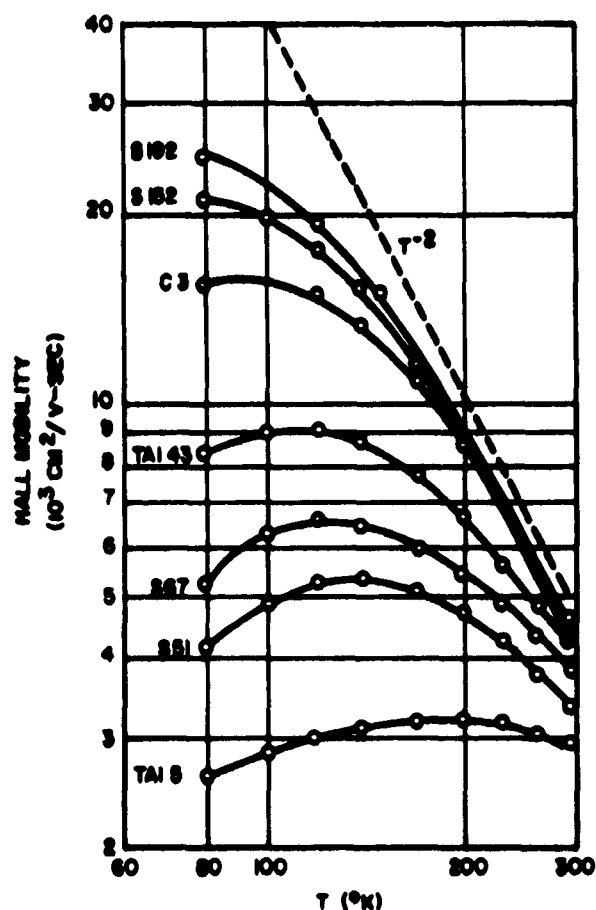
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Mobility



Measured Hall mobilities μ_H as a function of temperature for n-type indium phosphide. Values for C3 have been adjusted to give $4300 \text{ cm}^2/\text{v-sec}$ at 290°K . single crystal. [Ref. 8]

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Mobility

<u>Symbol</u>	<u>Value</u>	<u>Type</u>	<u>Temp.</u>	<u>Test Conditions</u>	<u>Ref.</u>
μ_n	4600		3000K	$n=5 \times 10^{16}/\text{cm}^3$	20
μ_p	100		3000K	$n=3 \times 10^{17}/\text{cm}^3$	20
μ	190	p-single	3000K	$n=5 \times 10^{16}/\text{cm}^3$ for	3
μ	1200	p-single	770K	cadmium doping	3
μ_n	4500	n-single	3000K	$n=6 \times 10^{15}/\text{cm}^3$	3
μ_n	23400	n-single	770K	pure	3

<u>n-type Crystal</u>	<u>Concentration of electrons at 2900K, $10^{16}/\text{cm}^3$</u>	<u>Mobility at 2900K, $\text{cm}^2/\text{v-sec}$</u>	<u>Mobility at 770K, $\text{cm}^2/\text{v-sec}$</u>
TA15	54	2910	2600
S51	7.4	3400	4170
S67	0.37	3800	4170
TAI43	4.3	4200	8300
C3	2.6	3800	13,500
S152	0.83	4300	21,000
S192†	0.63	4500	23,400

† These values represent the results for a number of samples.

[Ref.8]

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

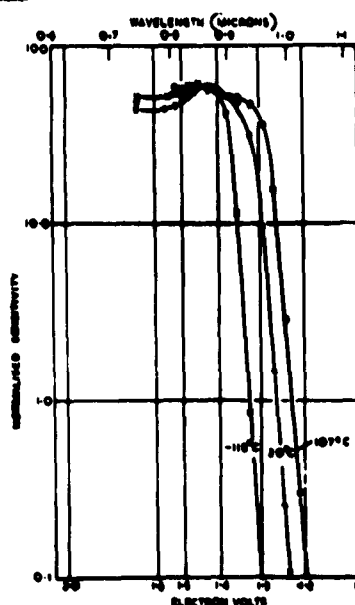
MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Photoelectronic Properties



Response curves for a p-type indium phosphide photodiode.

Polycrystal

Diode was a point contact on p-type [Ref. 18]
polycrystalline material. The
photovoltaic threshold (where response
is 1/2 peak value) is given as a
function of temperature by
 $E_g = 1.44 - 4.5 \times 10^{-4} \text{ TeV}$

Piezoelectric Properties

Piezoresistance

π n-single 300°K $n=2.5 \times 10^{16}$ [Ref. 19]
isotropic compression

$$-1/P \cdot \delta R/R = (\pi_{11} + 2\pi_{12}) = -(8.2 \pm 0.3) \times 10^{-12} \text{ cm}^2/\text{dyne}$$

Current and stress along (110) direction:

$$1/X \cdot \delta R/R = 1/2(\pi_{11} + \pi_{12} + \pi_{44}) = -(1.3 \pm 0.5) \times 10^{-12} \text{ cm}^2/\text{dyne}$$

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

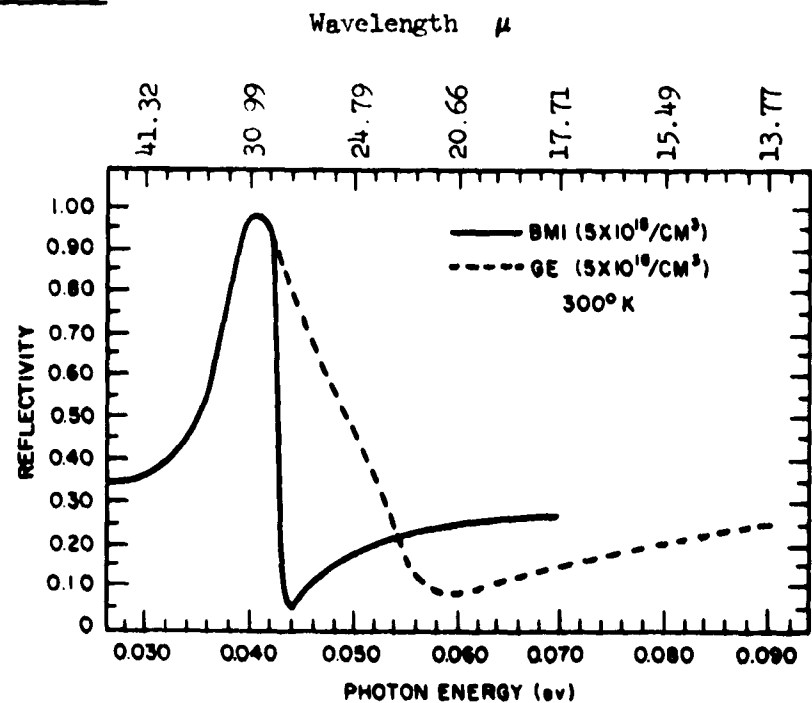
MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Reflectivity



Reflectance spectra (300°K) of InP for two samples having different free electron densities as noted. Low concentration sample exhibits clear reststrahl peak from which longitudinal and transverse optical phonon energies are found to be $h\nu_L = 0.043\text{eV}$ and $h\nu_T = 0.036\text{eV}$. Sample are n-type, polycrystal.

[Ref. 13]

Symbol	Value	Type	Test Conditions	Ref.
R	0.25	n-poly	$\lambda = 4-15 \mu$ $\rho = 0.1 \text{ ohm cm}$	16

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

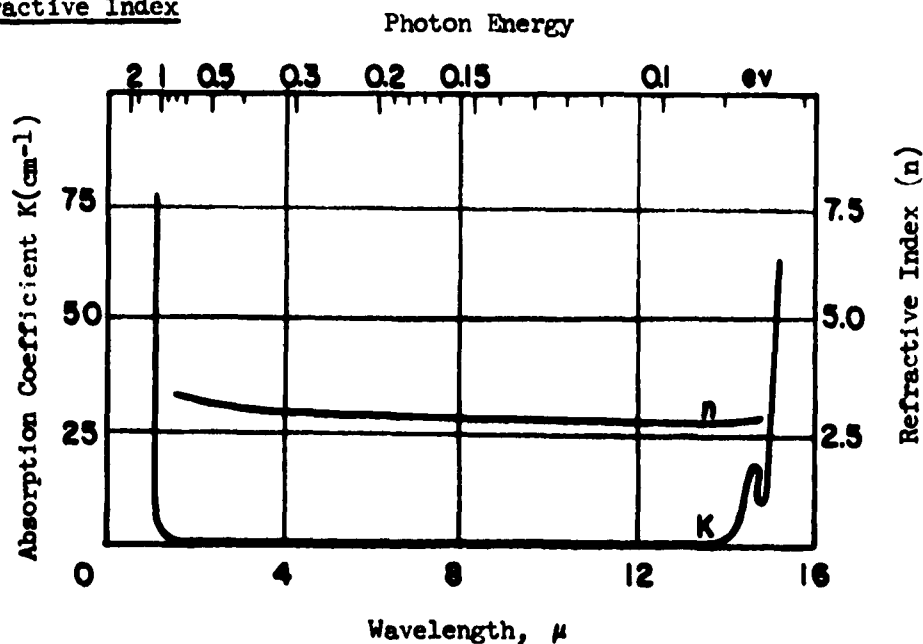
MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

Refractive Index



Indium Phosphide; $\rho = 0.1 \Omega\text{cm}$, n-type, single crystal. [Ref. 15]
 $n = 3.1$ in infra-red.

<u>Symbol</u>	<u>Value</u>	<u>Type</u>	<u>Test Conditions</u>	<u>Ref.</u>
n	3.26		Room Temperature	10

Thermoelectric Properties

Seebeck Effect

S	-400 $\mu\text{V}/^\circ\text{C}$	n-single	300°K $n=5 \times 10^{15}$	13
S	-100 $\mu\text{V}/^\circ\text{C}$	n-single	300°K $n=5 \times 10^{18}$	13

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

References

1. AUSTIN, I.G. Infra-red Faraday Rotation in InAs and InP. Journal of Electronics and Control, vol. 8, no. 3, p. 167-169, March 1960.
2. BATTELLE MEMORIAL INST., Columbus, Ohio. Theoretical and Experimental Studies Concerning Radiation Damage in Selected Compound Semiconductors, by R.K. Willardson, F.J. Reid and others. Interim progress rept. no. 8 30 Mar-30 June 59, 39 p. Contract AF 33(616)3747. ASTIA AD-219 228.
3. DAVID SARNOFF RESEARCH CENTER, Princeton, N.J. High-Temperature Semiconductor Devices, by A. Amith, L. Ekstrom and others. Progress rept. no. 4, 15 Feb-15 June 58. 30 June 58, 46 p. Contract AF 33(616)5029. ASTIA AD-204 185.
4. FOLBERTH, O.G. and H. WEISS. Herstellung und Elektrische Eigenschaften von InP und GaAs. [Preparation and Electrical Properties of InP and GaAs.] Zeitschrift für Naturforschung, vol. 10a, no. 8, p. 615-619, August 1955.
5. GLICKSMAN, M. and K. WEISER. Electrical Properties of p-Type InP. Physics and Chemistry of Solids, vol. 10, no. 4, p. 337-340, 1959.
6. GRENDELMAIER, R. Irradiation of P-N Junctions with Gamma Rays: A Method for Measuring Diffusion Lengths. Proceedings of the I R E, vol. 46, no. 6, p. 1045-1049, June 1958.
7. GLICKSMAN, M. The Magnetoresistance of Electrons in InP and GaAs. Physics and Chemistry of Solids, vol. 8, p. 511-515, January 1959.
8. GLICKSMAN, M. and K. WEISER. Electron Mobility in InP. Journal of the Electrochemical Society, vol. 105, no. 12, p. 728-731, December 1958.
9. HARMAN, T.C., J. I. GENCO, W.P. ALLRED and H.L. GOERING. Preparation and Some Characteristics of Single-Crystal Indium Phosphide. Journal of the Electrochemical Society, vol. 105, no. 12, p. 731-735, December 1958.
10. HILSUM, C. and A.C. ROSE-INNES. Semiconducting III-V Compounds. Edited by H.K. Henisch. New York, Pergamon Press, 1961.
11. MINDEN, HENRY T. Intermetallic Semiconductors. Sylvania Technologist, vol. 11, no. 1, p. 13-25, January 1958.

DATA SHEET

ELECTRICAL AND ELECTRONIC PROPERTIES

MATERIALS CENTRAL
AERONAUTICAL SYSTEMS DIVISION
AIR FORCE SYSTEMS COMMAND

SEMICONDUCTOR MATERIALS

June 1962

INDIUM PHOSPHIDE

References (Continued)

12. MOSS, T.S. and A.K. WALTON. Measurement of Effective Mass of Electrons in InP by Infra-red Faraday Effect. Physica, vol. 25, no. 11, p. 1142-1144, November 1959.
13. NEWMAN, R. Optical Properties of n-Type InP. Physical Review, vol. 111, no. 6, p. 1518-1521, September 15, 1958.
14. OSWALD, F. Optische Bestimmung der Temperaturabhängigkeit des Bandabstandes von Halbleitern des Typus AIII^{IV}B^V. [Optical Determination of Temperature-Dependence of Energy Gap in Semiconductors of Type AIII^{IV}B^V.] Zeitschrift für Naturforschung, vol. 10a, no. 12, p. 927-930, December 1955.
15. OSWALD, F. and R. SCHADE. Über die Bestimmung der Optischen Konstanten von Halbleitern des Typus AIII^{IV}B^V im Infraroten. [On the Determination of the Optical Constants of Semiconductors of Type AIII^{IV}B^V in the Infrared.] Zeitschrift für Naturforschung, vol. 9a, no. 7/8, p. 611-617, July-August 1954.
16. OSWALD, F. Über die optischen Eigenschaften von Indiumphosphid im Infraroten. [On the Optical Properties of Indium Phosphide in the Infrared.] Zeitschrift für Naturforschung, vol. 9a, no. 2, p. 181, February 1954.
17. PALIK, E.D. and R.F. WALLIS. Infrared Cyclotron Resonance in n-Type InAs and InP. Physical Review, vol. 123, no. 1, p. 131-134, July 1, 1961.
18. REYNOLDS, W.N., M.T. LILBURNE and R.M. DELL. Some Properties of Semiconducting Indium Phosphide. Proceedings of the Physical Society, vol. 72, pt. 3, p. 416-421, March 1958.
19. SAGAR, A. Piezoresistance in n-Type InP. Physical Review, vol. 117, no. 1, p. 101, January 1, 1960.
20. BEER, A.C. Semiconducting Compounds - A. Challenge in Applied and Basic Research. Journal of the Electrochemical Society, vol. 105, no. 12, p. 743-751, December 1958.

PUBLICATIONS OF THE ELECTRONIC PROPERTIES INFORMATION CENTER

Summary Reviews and Data Sheets

- DS-101. Cadmium Telluride - Data Sheets. M. Neuberger. June 1962.
- DS-102. Indium Phosphide - Data Sheets. M. Neuberger. June 1962.
- DS-103. Indium Telluride - Data Sheets. M. Neuberger. June 1962.
- DS-104. Magnesium Silicide - Data Sheets. M. Neuberger. June 1962.
- DS-105. Polyethylene Terephthalate - Data Sheets. John T. Milek. June 1962.
- DS-106. Polytetrafluoroethylene Plastics - Data Sheets. Emil Schafer. June 1962.
- DS-107. Polytrifluorochloroethylene Plastics - Data Sheets. Emil Schafer. June 1962.

Other Reports

- 5171.2/8 Information Retrieval Program. Electronic/Electrical Properties of Materials. First Quarterly Report. E.M. Wallace. October 10, 1961.
- 5171.2/8 Information Retrieval Program. Electronic/Electrical Properties of Materials. Second Quarterly Report. E.M. Wallace. January 15, 1962.
- 5171.2/32 Information Retrieval Program. Electronic/Electrical Properties of Materials. Third Quarterly Report. E.M. Wallace. April 15, 1962.
- P62-18 Electrical and Electronic Properties of Materials Information and Retrieval Program. Final Report. H. Thayne Johnson, Emil Schafer, and Everett M. Wallace. June 1962.
- S-1 Insulation Materials Descriptors Used in the Electrical and Electronic Properties of Materials Information Retrieval Program. Emil Schafer. July 1962.

- S-2 Semiconductor Materials Descriptors Used in the
Electrical and Electronic Properties of Materials
Information Retrieval Program. Emil Schafer.
September 1962.
- 5171.2/73 Information Retrieval Program. Electronic/Electrical
Properties of Materials. Fourth Quarterly Progress
Report. H.T. Johnson. September 15, 1962.
- P62-18 Electrical and Electronic Properties of Materials
Information Retrieval Program. H. Thayne Johnson,
Donald L. Grigsby, and Dana H. Johnson. April 1963.